

FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE List of Information Cited by Applicant Page 1 of 1	ATTY. DOCKET NO. SURR.79	SERIAL NO. 09/994,576
	APPLICANT HUYN	
	FILING DATE NOVEMBER 27, 2001	GROUP 1645 1871

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EXAM. INITIAL		DOCUMENT NUMBER	DATE	NAME	CLS	SUB- CLS	FILE DATE
cm	AA	6,059,724	05/09/00	Campell			
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cm	AR	WO 00/70340	05/11/00	WIPO			
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1	AZ	Eisen et al. (1998) Proc. Natl. Acad. Sci. 95, 14863-14868
	AAA	Brown et al. (2000) Proc. Natl. Acad. Sci. 97, 262-267
	AAB	Guyon et al., Machine Learning (submitted for publication), available at http://www.biowulftech.com/publications/index.html , last modified or visited on 12/05/01, Gene Selection for Cancer Classification using Support for Vector Machines
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EXAMINER <i>Chapman</i>		DATE CONSIDERED 3/10/03
*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.		

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U.S. DEPARTMENT OF
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ATTY. DOCKET NO.

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List of Information Cited by Applicant

Page 1 of 1

APPLICANT

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CR	AY	Martin et al. (April 2000) Cancer Res. 60:2232-2238
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EXAMINER <i>Cheng</i>		DATE CONSIDERED 7/10/03
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